

Review

Applications of Oxide Coatings in Photovoltaic Devices

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Abstract: Metalloid and metal based oxides are an almost unavoidable component in the majority of solar cell technologies used at the time of writing this review. Numerous studies have shown increases of $\geq 1\%$ absolute in solar cell efficiency by simply substituting a given layer in the material stack with an oxide. Depending on the stoichiometry and whether other elements are present, oxides can be used for the purpose of light management, passivation of electrical defects, photo-carrier generation, charge separation, and charge transport in a solar cell. In this review, the most commonly used oxides whose benefits for solar cells have been proven both in a laboratory and industrial environment are discussed. Additionally, developing trends in the use of oxides, as well as newer oxide materials, and deposition technologies for solar cells are reported.

Keywords: oxides; solar cells; photo conversion efficiency

1. Introduction

Many review articles about oxides have been published but most of them concentrate on specific properties such as electrical conductivity [1], simultaneously high optical transparency and electrical conductivity [2], photoconductivity [3], dielectric constant [4], catalysis [5], electronic structure [6], among others. The wide range of properties of oxides, not only suggests, but demonstrates the versatility of oxides as functional materials. Indeed, the potential of these important materials can be exploited to enhance the performance of opto-electronic devices such as photovoltaic (PV) cells. It follows that an assessment of the various oxides available and how their properties can be used in PV cells would be useful for the researcher looking to enhance the photo-conversion efficiencies above the present day levels while keeping the device cost as low as possible. In general, different materials are required to perform different functions in a PV cell, namely:

- Electrodes are necessary to convey the photo-generated carriers to an external load;
- Antireflection coatings (ARCs) are applied to PV cells to ensure a gradual increase of the refractive index as incident photons traverse from air through to the absorber so as to reduce the backward reflection losses;
- Back reflectors are used to prevent energy waste when the absorber is too thin to absorb all the incident photons in one pass;
- Buffers and/or barriers are used to prevent irregularities at interfaces from affecting PV cell performance. These may be defect states caused by lattice mismatch, too large energy band offsets or diffusion of contaminants into the absorber, among others.

2. Ideal Material Characteristics for Various Functions in PV Cells

In order to identify those oxides that are suitable for use in PV cells, it is important to familiarise oneself with the ideal material requirements for high power conversion efficiency (PCE). All PV cells consist basically of a semiconductor material capable of absorbing a certain portion of the solar spectrum and adjacent layers (electrodes) required to extract the photo-generated carriers for conveyance to an external electrical load. Therefore, the optical and electronic properties of each material in the PV cell should be tuned to prevent unnecessary loss of incident photons through reflection and parasitic absorption, as well as, to minimise loss of the photo-generated power via recombination at trap states and electrical resistance losses. Additionally, the PV cells should maintain their initial efficiency over a lifetime of at least 20 years and should therefore not only be mechanically stable, but also resistant to degradation caused by exposure to the environment.

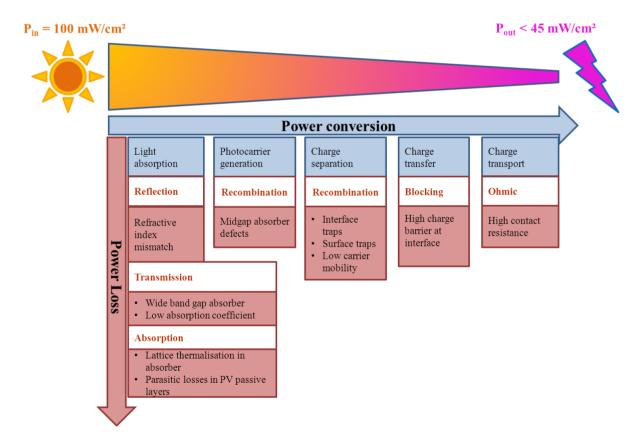
2.1. Appropriate Opto-Electronic Properties

The main power conversion and power loss processes in a PV cell are illustrated in the schematic in Figure 1. The first key condition for high PCE is that the photoactive (absorber) layer has a narrow enough band-gap (around 1-2 eV) to absorb photons with a wide range of energies, most especially, in that portion of the solar irradiance with high intensity. The second key condition is that as many as possible incident photons enter the photoactive layer (absorber) of the device for conversion into charge carriers. This requires that all other "photo-passive" but functional layers in the PV cell that lie in the path of photons traversing to the absorber should not absorb or back reflect any of the light before it reaches the absorber. That is, the window layers must be highly transparent *i.e.*, have a wider band gap than the absorber and thus a much lower absorption coefficient in the spectral range of light used for photo-conversion. Where reflection losses are undesirable, the functional layer must have a refractive index close to that of the absorber material.

Electrically, the components of the PV cell should minimise recombination of photo-generated electrons and holes in order to maximise the photocurrent. As a consequence, the absorber must have a low defect density so that the minority carriers have a long enough life-time to transverse to the electrodes for collection. Also, the materials adjacent to the absorber should have a small conduction band (CB) or valence band (VB) offset for electron and hole transfer, respectively, across the interface and be free from trap states that would enhance recombination of the photo-generated carriers. In order

to collect as many of the photo-generated carriers as possible for use in an external load, the terminal contacts/electrodes of the PV device should be highly conductive. High conductivity requires high hole/electron mobility and/or high hole/electron density, or both. However, as will be discussed later, there are some instances when an insulating layer is required to prevent recombination of photo-generated carriers before they can be used to drive an external load. In this case, the insulating layer should be very thin to allow passage of photo-generated carriers via tunnelling. On the other hand, the absorber should have an appropriately wide band-gap to ensure the highest possible value of the photo-generated voltage which is in conflict with the requirement for maximal photon absorption. The junction should be of a strongly rectifying behavior to prevent shunting which would reduce the voltage of the PV cell. Additionally, the photo-generated voltage should be maintained as high as possible by optimising the energy band offsets at different interfaces of the PV cells. The terminal voltage of the cell should further be preserved by avoiding resistive losses in the contacts/electrodes.

Figure 1. Power conversion and power loss processes in a photovoltaic (PV) cell. Each of the losses can occur at several interfaces and regions of the PV cell. The maximum power output is based on the current experimental efficiency record [7].



2.2. Suitability for Manufacturing

In order for materials that show promisingly high photo-electrical conversion efficiency in the laboratory, to be implemented in commercial products, they must be compatible with certain technical demands. The first criterion for the adaptation of a material into a commercial product is the cost involved either in purchasing of raw materials, processing and yield or even in environmentally friendly end-of-life disposal. The abundance of a material in the earth's crust contributes significantly to the

material costs, such that most abundant elements are relatively inexpensive. In this respect, the wide use of oxides in PV cells may be attributed to the fact that oxygen is the most abundant element on the earth. Similarly, since silicon is the second most abundant material and arguably the most abundant elemental photo-active material it is not surprising that it is the dominant material for photovoltaic cells.

However, abundance does not always directly translate to lower material cost as extraction of a given element from its natural form or ore, may involve energy intensive processes that translate to a higher price than less abundant materials. Therefore, the simplest way to minimise material costs would be to use as little as possible of the material for a given function. This means that the absorber should ideally have a direct band gap and a high absorption coefficient so that minimal material is required in the PV cell. Similarly, the electrodes must be highly conductive so that very thin layers are sufficient to transport the photo-current with minimum resistance losses. Less energy intensive processing using solutions carried out at atmospheric pressure and at reasonably low temperatures are preferable to vacuum processing and high temperature processing, although in most cases the material properties are inferior despite the lower processing costs. As the volumes of PV cells increase drastically, or when hazardous components are unavoidable, the cost of recycling or disposal at the end of the device's life may become a significant fraction of the overall PV cell costs.

2.3. Toxicity and Environmental Benignity

It is important that not only the materials used in a PV cell are non-toxic but that also the manufacturing processes thereof are environmentally benign. This requirement is also in harmony with the "green" philosophy which is meant to make photovoltaics competitive in comparison to other energy generating technologies such as nuclear power and fossil fuels. The use of several hazardous elements such as Cd, Pb, Hg and the radioactive elements including, Po and Ur, among others, in devices appropriate for the public market is severely restricted. Additionally, while the oxides of essentially poisonous elements may themselves be considered to be non-hazardous because of their chemical stability, some oxides such as BeO are toxic.

2.4. Environmental and Chemical Stability

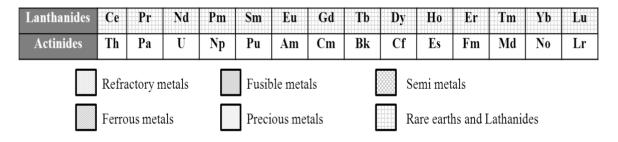
PV cells are expected to deliver the nameplate output for at least 20 years after installation in the field and thus failure of the device before this duration is to be avoided. In service, perhaps the biggest threat to PV cells from the environment is moisture, which accelerates oxidation of the different components. The PV cell material components should therefore resist degradation by air (oxygen), moisture and impurity diffusion. Where the materials are not environmentally/chemically resistant, an encapsulation and/barrier should be provided to protect them. However, although PV cells in the field are encapsulated to prevent moisture ingress, it is preferred that the device should still be somewhat stable to the environment to extend its lifetime in case the encapsulation gets damaged. For PV cells grown on glass, the diffusion of sodium into the PV cell is of particular concern as it is accelerated by the presence of a bias voltage [8]. Interdiffusion of elements from sources internal to the PV cell device may also be detrimental to the PV cell performance, necessitating diffusion barriers.

3. Survey of Oxides with Proven or Potential Application in PV Cells

Oxygen is a group 16 (also known as chalcogens) element and exists in pure form as a diatom O_2 or as ozone O_3 . The most common form is the diatomic molecule O_2 which contains two unpaired electrons hence the double covalent bonding and is therefore paramagnetic. Oxygen has several oxidation states namely O^{-2} , O_2^{-2} and O_2^{-1} corresponding to oxides, peroxides and super oxides. Typically, an oxide is formed when a metal/metalloid donates two electrons to the 2p orbital of the oxygen atom such that the oxygen orbitals form the valence band of the resulting oxide. Since this review is confined to solid state photovoltaic devices, only solid oxides are considered. The type of oxide formed depends to a large extent on the position of the bonding cation in the periodic table (see Figure 2).

Figure 2. Periodic table of elements. For convenience, technologically relevant classifications [9] of elements with similar properties transcend the periodic groups as shown in the shaded areas.

1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18
Н																	He
Li	Be											B	C	N	0	F	Ne
Na	Mg											Al	Si	Р	S	Cl	Ar
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Ph	Pd	Ag	Cd	In	Sn	Sb	Te	Ι	Xe
Cs	Ba	La	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn
Fr	Ra	Ac	Rf	Db	Sg	Bh	Hs	Mt	Ds	Rg	Cn						



For instance, the acidity of the oxide increases with the cation charge *i.e.* going left of and/or up the periodic table. Similarly, the electrical conduction depends on the type of bond between the cation and the oxygen especially as far as which electrons are involved in the bonding [10]. Oxides with ionic bonds typically have a high dielectric constant and are usually insulating while those with more covalent bonds have a narrower optical band gap and are capable of becoming semiconducting under certain circumstances. At first glance, many stoichiometric oxides do not fulfil the functional requirements for PV cells. However, sub-stoichiometry, either hypo-(excess cation) or hyper-(excess oxygen) stoichiometry combined, at times, with doping may introduce wide variations in the metal oxide properties making them suitable for a wide palate of functionalities. Theoretical calculations supported by experimental evidence from X-ray absorption spectroscopy XAS, high resolution X-ray photoelectron spectroscopy XPS and X-ray emission spectroscopy XES, among others have given

insights into the electronic band structure of different oxide materials and have been useful in understanding their material properties and in identifying new oxides for use in PV devices.

Most elements have multiple oxides corresponding to various oxidation states [11]. Moreover for the same oxidation state, slight differences in stoichiometry and/or coordination structure lead to different phases with markedly different physical properties. For conciseness, in this work, only those oxides known or identified as useful components of PV cells are described. Such oxides tend to invariably be the most thermodynamically stable form since the processing of PV cells involves different steps with various temperature regimes. Further discussion of oxides shall be confined to those elements in the periodic table which have been cited in the literature in connection with a working PV cell device. Because of gradual variations across and down the periodic table, it is also convenient to group the oxides to be discussed using a classification that combines those elements with similar properties *i.e.*,: alkali metals (all group 1), alkali-earth metals (all goup 2), rare earths and lanthanides (Sc, Y, La and the lanthanides), refractory metals (Ti, Zr, Hf, V, Nb, Ta, Cr, Mo, W and Re), ferrous metals (Mn, Fe, Co and Ni), precious metals (Cu,Ag, Au), fusible metals (Zn, Cd, Hg, Ga, In, Tl, Sn, Pb, Sb, Bi) and semimetals (B, Al, C, Si, Ge). Alkali-earth metals cover all group 2 elements but since their oxides are very reactive with water, they are of little interest for PV cell devices since processing would be difficult to handle. The oxides of rare earth and lanthanide elements are discussed later in Section 6 as they are an emerging material for PV cells.

3.1. Refractory Metal Oxides

The refractory metals consist of Ti, Zr, Hf, V, Nb, Ta, Cr, Mo, W and Re, all of which, are transition elements and thus possess several oxides due to variable oxidation states of the cation. Typically, the d orbitals of transition metal ions are split into a triply degenerated t_{2g} band (d_{xy} , d_{xz} , and d_{yz} orbitals) and a doubly degenerated e_g band ($d_{x^2y^2}$ and d_{z^2} orbitals). Also, the bonding states are split to give σ - and π -orbitals corresponding to the high- and low-binding energy portions of the valence band, respectively.

Titanium dioxide can occur with rutile, brookite or anatase crystalline structure. However, since most PV cell processing occurs at relatively, low temperatures, the anatase phase is preferred. The bottom of the conduction band is dominated by Ti 3d orbitals (which are unoccupied for Ti⁴⁺) where the d_{xy} states are non-bonding and lie at the conduction band minimum [12]. The top of the valence band is occupied by O 2p states with non- bonding O p_{π} at the highest energy level. The optical band gap of anatase TiO₂ is 3.2 eV while the refractive index for visible light is around 2.2–2.4 [13,14]. Stoichiometric TiO₂ with a Ti⁴⁺ 3d⁰ 4s⁰ configuration is an insulator whereas, TiO with a Ti²⁺ 3d² 4s⁰ configuration has metallic conduction due to the availability of two free electrons in the d orbital. The hypo-stoichiometric anatase form TiO_{2- δ}, is an n-type semi-conductor due to oxygen vacancies and interstitial titanium atoms and high n-type conductivity with high visible light transparency is possible via doping with Nb [14]. Dense thin film TiO_x is usually grown by magnetron sputtering [15], pulsed laser deposition [14] or by pyrolysis of titanium isopropoxide [16].

Molybdenum has several oxides but the stable phases are MoO_2 and MoO_3 , the latter shows metallic conduction while the latter is insulating. Semiconductivity in MoO_3 is caused by hyper-stoichiometry via the presence of oxygen vacancies which coupled with a wide band gap makes it an interesting

material for solar cells. Molybdenum oxide is one of the few oxides with a relatively high work function of 5.3-5.7 eV [17]. Molybdenum oxide coatings for solar cells have been fabricated using thermal evaporation [18]. Other transition metal oxides such as ZrO_2 , HfO₂ and Ta₂O₅ are also transparent in the visible region and are nominally insulating [19]. Tungsten has several oxides, though the most stable phase is WO₃ with an optical band gap of 2.7 eV and a monoclinic crystalline structure. Tungsten oxide thin films have been grown using thermal evaporation for use in solar cells [20].

3.2. Oxides of Ferrous Metals

Ferrous metals are a class of transition metals that are ferromagnetic which includes Mn, Fe, Co and Ni. Nickel oxide exhibits p type conductivity formed by Ni vacancies which form holes in the O 2p band. Nickel oxide has a rock salt structure, a relatively high work function of 4–5.3 eV, is chemically stable and is transparent to visible light (optical band gap ~3.8 eV). On the contrary, due to half-filled d-shells, d-d transitions are possible in the oxides of iron, cobalt and chromium and therefore they are not transparent to visible light.

3.3. Oxides of Precious Metals

The precious metals consist of Cu, Ag and Au all of which exhibit the highest room temperature electrical conductivity and reflectivity of known metals. Due to cost restrictions, it is doubtful that oxides containing significant amounts of Au and Ag would be used in solar cells. In the quest to find low cost materials, there is a revival in the research of copper oxide based PV cells since copper can form different oxides and thus the band gap can be tuned from 1.4 eV for CuO to 2.1 eV for Cu₂O [21]. It is however, reported in the literature that the p-type cuprous oxide Cu₂O with a band gap of \sim 2 eV can be used as a photovoltaic absorber [22,23].

3.4. Oxides of Fusible Metals

The fusible metals group consists of zinc, cadmium, mercury, gallium, indium, thallium, tin, lead, antimony and bismuth, all of which have relatively low melting points. The highest melting point is 419 °C for zinc and 630.63 °C for antimony [9]. The oxides of zinc (ZnO), cadmium (CdO), gallium (Ga₂O₃), indium (In₂O₃) and tin SnO₂ possess a wide optical band gap, a large energy separation between the CBM and the second conduction band ensuring high visible light transparency; a low CBM with respect to the vacuum level, for high dopability, as well as a small effective mass, for high electron mobility. The metal cations of these TCOs have an electronic configuration of the form $(n-1)d^{10}ns^0$ and thus the spherical nature of the vacant s orbitals form highly dispersed conduction bands with small effective electron masses allowing high electron mobilities [24]. These so-called s-type metal oxides form a class of materials known as transparent conductive oxides which find widespread use in PV cells. On the other hand, in SnO, PbO, Sb₂O₃ and Bi₂O₃, the s orbital is fully occupied and therefore lies inside the valence band, the electrons are donated from the p-orbital [10] and thus these oxides are nominally p-type. Presently, the search for a p-type transparent semiconductor with conductivity and transparency similar to the known n-type TCOs is a subject of intense research [25,26].

At normal pressure and temperature, ZnO crystallizes in the wurtzite form with layers occupied by zinc atoms alternating with layers occupied by oxygen atoms. The Zn atoms are tetrahedrally coordinated to four O atoms, where the Zn 3d-electrons hybridize with the O 2p-electrons [27]. The conduction band minimum is dominated by Zn 4s states while the top of the valence band maximum is mainly made up of O 2p states. Intrinsic ZnO is an n-type conductor and depending on the deposition and treatment procedure, n-type doping may be achieved via Zn interstitials or oxygen vacancies although, many groups have observed unintentional doping caused by residual hydrogen which is a low level donor [28]. The substitution of Zn on lattice sites by Al [27], Ga [29] or B [30] results in extrinsic n-type doping. Although p-type conduction has been reported via nitrogen doping, the resistivity remains very high and there is still much debate in the literature about the stability (and possibility) of p-type doping in ZnO [27]. Zinc oxide has a wide band gap of around 3.2 eV and a visible light refractive index varying from 1.9 to 2.0 [13].

Indium oxide In_2O_3 crystallises in the bixbyite crystal structure with six fold coordination of the In^{3+} ion and four fold coordination of the oxygen [31]. The valence band maximum is composed of O 2p states while the bottom of the conduction bands is made up of In 5s states [31]. The O 2p states in the valence band are hybridized with In 4d core level states leading to an indirect band gap [32] in addition to a direct band gap of 3.2 eV. The work function of In_2O_3 varies from 5.5 eV in the intrinsic state to 4.8 eV as the tin dopant concentration is increased accompanied by a tenfold increase in the carrier density [33]. Tin doping induces n-type conductivity since the Sn 5s states lie just below the conduction band minimum [34].

The band gap of β -Ga₂O₃ is ~4.6 eV while that of α -Ga₂O₃ is ~5 eV. In β -Ga₂O₃, Ga ions occupy both octahedral and hexagonal sites. The valence band maximum is made up of O 2p states while the conduction band minimum is made up of Ga 4s states of Ga³⁺ ions at octahedral sites. The conductivity of β -Ga₂O₃ can be increased by electron donation from Sn while maintaining an optical band gap of 4.9 eV and transparency in the ultra violet and visible wavelength regions [35].

Tin oxide has a rutile crystalline structure with the Sn^{4+} ions in six-fold co-ordination and the O^{2-} ions in three-fold coordination. The top of the valence band is made up of O 2p states while the bottom of the CB is made up of empty Sn 5s states [36]. Unlike other post transition metal simple oxides, there is no hybridization of the Sn d and O 2p states in the valence band, hence SnO_2 has a direct band gap [32]. When doped with fluorine, F 2p states overlap with Sn 5s and Sn 5p states due to a relatively strong ionic interaction compared to Sn-O bonds as a result of the higher electronegativity of F. Also when an F⁻ ion replaces an O^{2-} ion, a free electron is released to the conduction band the minimum of which moves closer to the Fermi level thus reducing the band gap and increasing the conductivity [37]. Cation doping of SnO₂ with Sb is possible but this material is rarely used in solar cells. The visible light refractive index of SnO₂ is about 1.9–2.0 and the band gap is about 3.5 eV [13].

Cadmium oxide CdO crystallises in the cubic rock salt structure where the Cd^{2+} ion is octahedrally coordinated. The band gap of intrinsic CdO thin films is ~2.2 eV [38] although it can be shifted to higher energies by oxygen deficiency and extrinsic doping by Sn and transition metal elements. Although doped CdO has the highest mobility known of degenerately doped TCOs [39], it is not likely to be widely used in solar cells as Cd is hazardous.

Various phases of the simple lead oxide with O:Pb atomic ratios in the range of 1–2 exist. Accordingly, both the crystalline structure and band gap differ for the different phases [40]. Lead oxides

may therefore be useful as absorber materials for solar cells although it remains to be seen if such devices would be available on the market since lead is considered a hazardous substance.

3.5. Semi-Metal Oxides

The semi-metals or metalloids consist of boron, aluminium, carbon, silicon and germanium. Apart from carbon and silicon, the oxides of these elements are generally ionic and thus have very wide band gaps. In general, the solid oxides of semi-metals, have a refractive index ranging from 1.45 to 2 and are typically transparent to the eye [13]. Aluminium oxide has a wide optical band gap, a relatively high dielectric constant, a visible light refractive index of 1.54-1.62 [41] and is essentially insulating. Because of its hardness and chemical inertness, Al_2O_3 is favoured as a coating for mechanical protection and as a diffusion barrier. Aluminium oxide films used for solar cell applications are usually grown by sputtering from either ceramic or metallic targets [42] or by atomic layer deposition [43,44].

Once exposed to oxygen, the surface of silicon oxides to form SiO₂. Those familiar with silicon wafers are confronted with the exasperating need to constantly remove the native SiO₂ before proceeding with various process steps. On the other hand, most thin film solar cells are grown on glass substrates containing SiO₂ as the major component. SiO₂ crystallises mostly as quartz tetrahedral coordination of Si, one Si atom connected to four oxygen atoms with a Si-O-Si bond angle of 145 °, for amorphous and mc-Si, the tetrahedral coordination remains but the bond angle varies randomly. Oxygen vacancies form deep levels in the band gap and thus n-type doping is not possible hence SiO₂ is insulating. The energy level of Si 3s (CBM) is much higher than that of O 2p level (VBM) hence the band gap is very large and thus SiO₂ is transparent even in the ultra-violet optical wavelength region.

The surface of silicon wafers is usually heated in a furnace in an oxidizing ambient at temperatures around 1000 °C to form what is known as thermal SiO₂ on the exposed surface. Thermally grown SiO₂ thin films can also be obtained by oxidizing silicon thin films at elevated temperatures. Silicon oxide thin films used for other types of solar cells are usually grown using either plasma enhanced chemical vapour deposition (PECVD) or magnetron sputtering. Generally, thermally grown silicon oxide thin films are denser than those grown by either PECVD or sputtering and thus are better diffusion barriers [45]. However, CVD growth leads to denser SiO₂ films than either sol gel processed or evaporated SiO₂ [46]. PECVD grown silicon oxide films using silane and oxygen sources such as CO₂ and nitrous oxide are usually oxygen poor and thus the refractive indices are usually higher than the value of 1.46 for bulk SiO₂ [13,41,45]. Since the refractive index of SiO_x is too low for use as an ARC at the Si/air surface, nitrogen is added to form a SiON film. Increasing the nitrogen content in PECVD grown SiON films increases the refractive index [41,47] but reduces the plasma etch resistance [47].

3.6. Multinary Oxides

In this work, multinary oxides are taken to be those with oxygen combined with two or more distinct cation elements. Most multinary metal oxides consist of at least one transition metal element and another type of element. Generally, four types of ternary oxides exist which are classified according to the number of atoms of each constituent metal element such as spinels, bronzes, delafossites and garnets. For example in the CdO-SnO system, there exists a Cd_2SnO_4 , a spinel and $CdSnO_3$ a perovskite [48].

Spinels consist of metal oxides of the form AB_2O_4 where A/B pairs are made up of a divalent/trivalent cation pair or group four valence/divalent cation pair. Usually, cation A is a transition element and B is either Al, Ga or In such as Cd_2SnO_4 [49], $CdIn_2O_4$ [48,49], $ZnGa_2O_4$ [50] and In_2ZnO_4 [50], to name a few. The Cd containing spinels all show very high conductivity and wide band gaps and would be attractive as TCO materials, if it were not for concerns of toxic exposure.

Delafossites are oxides of the form ABO₂, where A is a monovalent ion such as Ag^+ or Cu^+ and B is a trivalent ion such as Al^{3+} , Ga^{3+} , In^{3+} or Tl^{3+} . Delafossites consist of alternating double layers of closed packed O atoms with B atoms occupying octahedral sites. Different types of doping are possible such as n-type for AgInO₂ and p-type for CuAlO₂ [25] and CuGaO₂ [26]. Simultaneous p-type conductivity and transparency is attributed to a large degree of hybridisation of the oxygen orbitals with $3d^{10}$ electrons in the Cu⁺ to lower hole effective mass because of a dispersive valence band [26].

Perovskites are mixed cation oxides of the general formula ABO₃ with a crystalline structure similar to the mineral perovskite CaTiO₃. The perovskite oxides consist of corner sharing BO₆ octahedra with the A cation occupying the 12-fold coordination site formed in the middle of each octahedra, where the cation A is larger than B. Usually one of the cations is a transition metal. A wide variety of binary metal oxides can take on the perovskite form because this structure is flexible and can accommodate elements of various sizes. As a result of crystalline distortions caused mainly by oxygen vacancies, the electronic and magnetic properties are widely variable. Examples of well-known perovskites include SrTiO₃ [6,51,52], YTiO₃ [6], LaTiO₃ [6], LaAlO₃ [52], BiFeO₃ [53] and KNbO₃ [53]. SrTiO₃ is transparent and is nominally insulating but becomes an n-type conductor due to vacancies near the Ti sites [6,51]. BiFeO₃ and KNbO₃ have smaller bandgap energies that lie in the visible and near infrared region, respectively, making them interesting for use as a photovoltaic absorber [53]. Another highly conductive transparent perovskite CdSnO₃ is derived from the CdO-SnO₂ system [48].

Amorphous oxide semiconductors are usually realised in multinary oxides that retain considerable charge carrier mobility, unlike polycrystalline oxides, when deposited at room temperature [54]. The properties of such films can be tuned by varying the content of one of the constituent cation elements. For instance in InGaZnO, increasing the Ga content increases the band gap [55], while crystallinity decreases with the Ga content [56] and mobility increases with the In content [56]. Using AOS is especially attractive for optoelectronic devices such as solar cells since high temperature steps required for crystallisation can be avoided, the composition can be gradually varied without changing the phase, the dielectric constant is isotropic and thus scattering of carriers at differently polarised grains is avoided and the absence of grain boundaries excludes the possibility of impurity diffusion across interfaces [19].

4. Typical Methods of Growing Oxide Coatings for Solar Cells

Most oxide coatings can be grown by a wide range of deposition technologies. However, the preferred deposition technology for a particular oxide coating may be determined by the availability of low cost source materials, the yield or source material utilisation efficiency of the process, the growth kinetics of particular crystalline structure, the nature and area of the surface to be coated and the deposition rate, among others. First we discuss deposition technologies that are well established both on a laboratory and on a production scale.

The majority of oxide coatings in industry are grown by chemical vapour deposition (CVD) where gas phase precursors are decomposed into the oxide once they arrive at the surface of the heated substrate to be coated. Several variants of CVD exist depending on the operating pressure—atmospheric pressure (APCVD) or low pressure (LPCVD); the mechanism used to decompose the precursor for example, plasma enhanced PECVD, when a plasma source is used to enhance splitting of the precursor molecule and the type of precursor used—metal organic MOCVD. CVD provides conformal coating and is hence suitable for coating thin films at a reasonably high deposition rate making it a well-established technique for industrial production. However, not all metal oxides can be grown by CVD because the available precursors may not have a low enough vapour pressure, may be highly pyrophoric or may be highly hazardous. More detailed discussions about CVD and PECVD can be found in previous reviews [13,41,57].

Sputtering is a vacuum based physical vapour deposition technique that is also widely used both in the laboratory and for production. During sputtering an applied voltage is used to generate a plasma that is confined close to a target material which ejects particles that are then transferred to the substrate to be coated. Metal oxides can be grown directly from ceramic targets by RF magnetron sputtering or with reactive DC sputtering from a metal target whereby oxygen is added to the sputter gas. Although the best film properties are obtained from RF sputtering, the equipment is not cost effective for industrial production. Sputtering facilitates the growth of compact oxide coatings with relatively good properties at low temperatures but offers little flexibility as separate targets are required to change the composition of the coating. More information about magnetron sputtering can be found in separate reviews [42,58].

Other deposition technologies are largely used on a laboratory scale. In colloidal based deposition a paste of nanoparticles of the oxide or a metal organic precursor mixed with a binder, is applied to the substrate via screen printing, doctor blading, spin coating, inkjet printing or dip coating then baked out to form the oxide film [59]. The films thus produced are porous but the processing costs are comparatively low because no vacuum is used. Film properties depend on factors such as viscosity of the paste and volatility of the binders.

Solution based coating using aqueous precursors to deposit a thin metal film such as by chemical bath deposition and electrochemical deposition are used where the substrate to be coated is sensitive to heat In chemical bath deposition, the substrate to be coated is immersed in an alkaline solution containing the metal ion [59,60]. The oxide is grown on the surface via hydrolysis of the cations which are then precipitated onto the substrate as an oxide. Usually different additives are added to the bath to aid nucleation at the substrate surface, to initiate the hydrolysis of the cation and an excess of alkali is required to prevent precipitation of the hydroxide in the bath.

In electrochemical deposition, the substrate to be coated forms one of the electrodes in an electrolytic cell separated by an electrolyte consisting of an ionic solution containing the precursors of the desired oxide [61]. The cations for the oxide are released from the electrolyte by a redox reaction when the applied potential is lower/higher than the redox potential of the reaction at the cathode/anode. Deposition at the substrate is possible either cathodically or anodically depending on the voltage bias. The deposition rate is controlled by concentration, pH and temperature of the electrolyte as well as by the voltage applied between the electrodes. The main disadvantage of electrochemical deposition is that the surface to be coated must be electrically conductive.

Atomic layer deposition (ALD) is a variant of chemical vapour deposition technique in which the substrate is subjected to a cyclic deposition and reaction process [62]. During deposition, the precursor for the cation is applied to the surface where it is absorbed as a monolayer and then the chamber is purged by an inert gas to remove excess precursor. For an oxide, the oxygen precursor is introduced to the surface, allowed to saturate and react with the cation to form an oxide, followed by an inert gas purge and then the cycle is repeated again by reintroduction of the cation precursor. ALD has the advantage of very fine conformity and the ability to closely control the deposited film thickness. However, the deposition rate is extremely slow.

5. Oxides in Contemporary Photovoltaic Cell Technologies

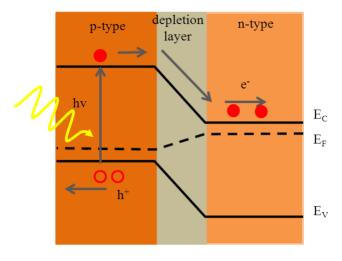
One of the earliest reports of improved PCE attributed to the presence of an oxide was for a so-called antireflection coated metal oxide semiconductor PV cell consisting of a GaAs|Au schottky barrier [63]. Although, the device made use of a Ta₂O₅ antireflection coating, the determining factor was the oxidation of the GaAs surface before coating with the gold which lead to an increase in open circuit V_{OC} and a remarkable relative efficiency jump of ~7%, in absolute terms, to 15% under terrestrial sunlight. Since then oxide coatings feature in different types of PV cells for the purpose of light management (reflectors, anti-reflection coatings and light scatterers), photo-carrier generation, charge carrier transport, defect passivation, band alignment and charge carrier blocking, among others. Several photovoltaic cell technologies based on materials such as silicon wafer, CdTe, CuInGa(S,Se) and thin film silicon have reached maturity and are available on the market to the general public. Other types of PV cells, especially those with the promise of low material cost, such as organic based, are the subject of intense research efforts. Yet further back the chain, new materials are being synthesized and device configurations suitable to achieve high efficiencies still have to be designed. In this section, a brief description of the operation of contemporary PV cells is given and the role of oxides in such devices discussed.

5.1. Crystalline Silicon PV Cells

Crystalline silicon photovoltaic cells are typically made of p-n devices consisting of a junction formed around the interface of two semiconductors with differently charged majority carriers. In such a device, a photocurrent arises from minority carriers generated by photo-excitation of the semiconductor absorber. An electric field present at the p-n junction separates the electrons and holes such that electrons flow to the n-doped layer and holes to the p-doped material, resulting in a net current flow. A schematic of the energy levels within the device is presented in Figure 3.

The spectral response of crystalline silicon ranges from ~350 to 1100 nm and with PV cells with absorbers of a few hundred microns thick, efficiencies in the range of 16%–24% are achievable. The oxides of Si, Ta, Ti and Al have been used as antireflection and/or passivation layers in crystalline Si PV cells. For good antireflection at the silicon/air surface, the oxides are required to have a refractive index of around two.

Figure 3. Schematic of the energy band diagram of an illuminated pn junction diode. E_C , E_F and E_V are the energy levels of the conduction band minimum, the Fermi level and the valence band maximum.



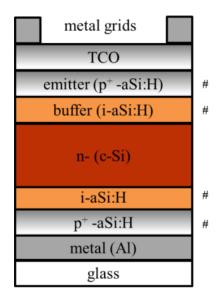
Passivation of c-Si PV cells is an unavoidable process step because the discontinuity of the crystal lattice at the surface, coupled with dopants segregating at the surface and bulk defects, promotes recombination of minority carriers that reach the surface of the silicon and thus reduce PCE [64]. The passivation of silicon by dielectric oxides takes place by creation of a fixed field of the same charge as the minority carriers in the silicon to repel and thus shield them from participating in recombination at the interface [65]. For n-type silicon PV cells, where the electron-hole pairs are generated close to the front of the device, a low front surface recombination is required so that minority carriers from the entire PV cell length can reach the rear emitter. The formation of thermal SiO_x at a c-Si wafer surface induces a positive fixed charge at the interface which prevents holes from approaching the surface. Since holes are the minority carrier in n-type material, field effect passivation of SiO_x is suitable for both highly and lightly doped n-type c-Si but only for lightly doped p-type c-Si [65]. On the other hand, an Al₂O₃ passivating layer can be used to accumulate a highly negative fixed charge near the interface with p-type c-Si and prevent electrons (minority carriers in p-type material) from approaching the surface and thus reduce recombination [43,44]. Ultra-thin Al₂O₃ passivation layers inserted between the aluminium back contact and the p-type Si emitter as well as between the aluminium contact grid and the n type Si emitter caused an improvement in the photo-conversion efficiency of a passivated and emitter and rear cell (PERC) from 21.1% to 21.7% [66].

However, for silicon wafer PV cells, SiO₂ does not provide an optimum antireflection because of the big difference in refractive indices and is thus less competitive than SiN grown by PECVD which can provide both passivation and antireflection functions, simultaneously [65,67]. Nevertheless, almost all passivation schemes in silicon PV cells require the insertion of a thin SiO_x layer between the n type silicon layer and the other passivating material [66,68].

Additionally thermally grown SiO_x is used as a diffusion mask for common dopants of silicon such as boron, phosphorous, arsenic and antimony, and has long been used as a mask for spatially selective impurity doping on c-Si wafers [69]. TiO_x has also been investigated as a phosphorus blocking barrier during the POCl₃ treatment to form a selective emitter in buried contact silicon PV cells [70].

The heterojunction with an intrinsic thin layer (HIT) cell is a special type of silicon wafer PV cell whereby the p-n junction is realized by the deposition of intrinsic-doped a-Si and p-type a-Si layers on an n-type c-Si wafer using PECVD [71]. On the rear side, intrinsic-doped a-Si and n-type a-Si layers form the back surface field (BSF). TCO grown by sputtering at the front and the back of the PV cells forms the electrodes and metal grids are provided to improve current collection. The TCO at the front side of the PV cell also acts as an anti-reflection coating. The layer stack of a typical HIT solar cell is illustrated in Figure 4.

Figure 4. Schematic of the layer stack in a heterojunction with thin intrinsic layer (HIT) silicon PV cell. The hash (#) symbols indicate layers that could be replaced by oxide films as discussed in the main text.



The present record efficiency on this type of PV cell is 24.7% which is quite close to the record for conventional Si wafer cells and is technologically important because all processes are done at low temperatures and on thin wafers of about 100 μ m thick [72]. Since amorphous silicon (a-Si:H) strongly absorbs blue photons, silicon sub-oxides have been explored to replace it in HIT cells. Recent investigations include replacement of the amorphous silicon (a-Si:H) emitter with doped amorphous hydrogenated silicon oxide a-SiO_x:H and doped hydrogenated microcrystalline silicon oxide (μ c-SiO_x:H) [73,74]. On the other hand, doped amorphous hydrogenated silicon oxide a-SiO_x:H as a passivation layer [75]. ZnO:Al has also been used as a conductive window layer in heterojunction PV cells based on n-type and p-type crystalline germanium wafers [76]. Amorphous InGa₂ZnO has been applied as the n-layer in a p-n hetero-junction on p-type wafer PV cells [55].

5.2. Polycrystalline Silicon Thin Film PV Cells on Glass

Due to the high cost of wafer fabrication, there is an increasing interest in the growth of polycrystalline silicon onto foreign substrates. Typically, the silicon thin films are grown using electron beam evaporation [77] or chemical vapour deposition [78] and are thereafter crystallised to form polycrystalline films. In solid phase crystallisation, the silicon is heated for several hours at about

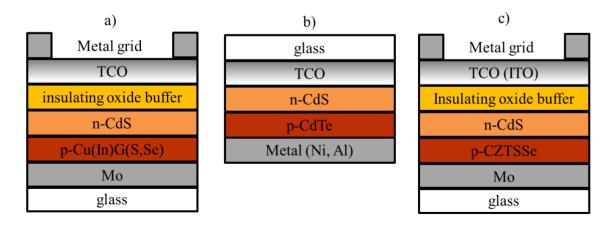
600 °C [77] and in some cases; metal thin layers such as aluminium are used to induce crystallisation in silicon seed layers which aid epitaxial growth of the subsequent "bulk" silicon layer [79]. In another technique known as liquid phase crystallisation, the silicon is melted using either a high power laser [80] or electron beam [78] and then crystallises as it cools. A TCO such as ZnO:Al at the front of the cell may be used as a front electrode and as antireflection coating [78]. An intermediate layer between the glass and silicon is required to block the diffusion of contaminants such as boron, sodium and iron from the glass into the silicon, to supply the doping ions to the silicon, to promote adhesion between the glass substrate and the silicon as well as in the substrate configuration and to act as an antireflection layer [80]. The intermediate layer consists of either SiO_x, SiC, SiN_x, or a stack consisting of one or two of these materials but the presence of SiO_x at the interface with polysilicon is mandatory for high values of photo-voltage and efficiency [80]. Efficiencies up to 11.7% have been reported on a laboratory scale for laser crystallised polysilicon PV cells [80]. The main challenges for this technology are the complicated contacting scheme.

5.3. Ternary Compound Semiconductor PV Cells

Several ternary compounds are known to be photo-active in a broad spectral range and these include chalcogenides such as Cu(In,Ga)(Se,S)₂ also referred to as CIGS(Se), CdTe, CuZnSn(Se,S) and the so-called III-Vs such as GaAs, InP, GaInP and GaInAs. In the following, discussion is devoted mainly to the chalcogenides which find more wide spread application and are less costly to process than the III-Vs.

Cu(In,Ga) (Se,S)₂, also known as CIGS, PV cells exhibit the highest efficiency of single p/n junction thin film PV cell made out of reasonably low cost semiconductors [81,82]. The PV cells are made up of a hetero-junction formed by p-type Cu(In,Ga) (Se,S)₂ absorber joined with an n-type layer as shown in the schematic in Figure 5a.

Figure 5. Layer stack for (**a**) a typical CIGS(Se) PV cell in the substrate configuration; (**b**) a CdTe PV cell; and (**c**) a CZTSSe PV cell. The direction of illumination is from the top downwards.



The n-type layer has a dual role of generating the depletion region at the junction and of acting as the buffer layer. This buffer layer prevents shunting at the n-type TCO/p-type absorber interface. However, the conduction band minimum (CBM) of the buffer should be close to or higher than that of the CIGS to supress the majority carrier recombination at the buffer/CIGS interface in order to maintain a high

photovoltage in the device [83]. ZnO and Zn_{1-x}Mg_xO [83,84], Zn(O,S) [85] and In(O,S,H) [86] have been used as buffer layers to replace CdS to alleviate toxicity concerns and to minimise optical losses of blue light in the window layer. Additionally, the TCO materials, ZnO(Al,Ga) [81,85] and ITO [83] which act as the window layer and as an electrical contact at the side of illumination, are an integral part of CIGS(Se) PV cells. In this case, high conductivity and high transparency are required. An intrinsically doped ZnO [81] layer placed between the buffer and the front TCO layer is used to reduce recombination by local shunts and to reduce damage to the absorber/buffer interface during further process steps. ZnO nanorods have also been used to reduce reflection losses at the front of CIGS PV cells [87]. Zn_{0.85}Mg_{0.15}O has been used to completely replace the i-ZnO|CdS double layer in CIGS PV cells with

efficiency than with CdS because of improved blue light quantum efficiency [88]. For CIGS grown on metal foils, SiO_x and Al_2O_3 have been used as barrier layers to prevent contamination of the absorber by impurities from the substrate [89,90]. The insulating oxides also act as electrical insulating layers for monolithic interconnection on metal substrates. Al_2O_3 coated on polymer substrates has been used to protect the subsequently grown CIGS device from ingress of moisture [91]. On the other hand, thin film alkali-silicate glass layers were grown on polymer films to supply sodium to the CIGS absorber [92].

only a small loss in efficiency [84]. In combination with i-ZnO, the use of ZnMgO buffer led to higher

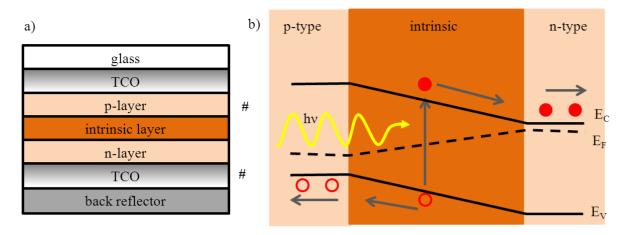
Another type of semiconductor pn-hetero-junction PV cells with significantly high photo-conversion efficiency are CdTe based. Such PV cells consist of a glass|TCO|n-CdS|p-CdTe|high work function metal structure, as illustrated in Figure 5b, with efficiency up to 19% on a laboratory scale [93]. Since CdTe processing requires high temperatures, SnO_2 :F is the front contact of choice because of its high thermal stability although the nearly 10 year efficiency record was reported using CdSnO [94]. A high resistance TCO such as $ZnSnO_4$ can be used to act as an insulating barrier such that the CdS thickness can be reduced to minimise parasitic absorption of short wavelength light [95]. Despite the concerns about the toxicity of CdTe, these PV cells have been successfully adapted to large scale production because of the simple processing.

Since indium and gallium used in Cu(In,Ga)S,Se PV cells are costly and there are concerns about the hazardous nature of Cd and the long term supply of tellurium for the CdTe, kesterite-type crystal structure, $Cu_2ZnSn(S_{1-x}Se_x)_4$ (CZTSSe) PV cells have emerged as an alternative. The PV cell structure is quite similar to that of Cu(In,Ga)S,Se as shown in Figure 5c and a record efficiency value of ~11% has been achieved [96].

5.4. PIN Solar Cells

Photovoltaic devices using defect rich semiconductors such as amorphous and microcrystalline silicon or germanium are made using the so-called pin configuration. Here, a defect rich intrinsically doped semiconductor is sandwiched between a heavily doped p and n-layer. The band diagram of a typical pin PV cell as well as a sketch of the cell structure is presented in Figure 6. Photon generation and carrier absorption take place in the intrinsic-layer. The different work functions of the doped layers result in a depletion layer that stretches over the width of the absorber which prevents the recombination of electron-hole pairs in the defect rich absorber. Since the doped regions have low carrier mobility, additional highly conductive contacts are required for lateral transport of the photo-carriers.

Figure 6. (a) Cell structure of a pin single junction PV cell in the superstrate configuration. The hash (#) symbols indicate additional layers that could be replaced by oxides. In the substrate configuration, the deposition order is reversed and light enters the cell through the n/TCO interface; (b) Schematic band diagram of a pin PV cell under normal operation.



In thin film silicon pin PV cells, oxides are used for different functionalities. Usually a SiO₂ [46] or SiON_x barrier layer grown between the glass and front electrode is used as an anti-reflection coating and as a barrier to sodium diffusion from the soda lime glass substrate. Since the front electrode of thin film silicon pin PV cell, must be both highly conductive and transparent for visible and infra-red light, transparent conducting oxides such as ZnO:Al [97], ZnO:B [30], ZnO:Ga [29] and SnO₂:F [29,46] are used for this purpose. Additionally, the surface texture achieved on these front electrodes plays a crucial role in light management by enhancing photo-current generation and thus increasing the overall PCE [29,30,46,97]. At the rear of the PV cell, a dielectric layer is required to increase the reflectivity of the metal reflector and to prevent the diffusion of metal ions from the back reflector because they can be grown at low temperatures. ZnO:B [100], ZnO:Al [101,102] and SnO₂:F grown by LPCVD, magnetron sputtering and APCVD, respectively, are well established TCOs for thin film silicon PV modules fabricated on an industrial scale.

In certain instances, a TiO_x layer is grown between the front TCO and the first doped layer of the thin film silicon pin PV cell to reduce reflection losses by providing a less abrupt change in refractive index at this interface [15,103]. The presence of intrinsic SiO_x on a TCO substrate is reported to promote a higher nucleation density of μ c-Si:H than on a-Si:H or ZnO [104,105]. When an ultra-thin undoped SiO_x buffer is inserted between the p- and i-layer of a μ c-Si:H PV cells, a roughly 1% absolute efficiency gain to 8.5% can be achieved [105]. The enhanced efficiency has been attributed to better antireflection at the front of the cell leading to a gain in photocurrent from low wavelengths and a reduction of boron contamination of the absorber which increased the V_{OC}.

Amorphous boron doped hydrogenated silicon oxide a-SiO:H, as a p-layer was reported to improve the efficiency of single junction a-Si:H pin PV cell compared to amorphous boron doped hydrogenated silicon carbide a-Si:C:H due to increased fill factor as a result of higher photoconductivity [106]. Wide band gap n-type and p-type hydrogenated microcrystalline silicon oxide (µc-SiO:H) films can be grown by PECVD with high conductivities [107–110]. A study using electron energy loss spectroscopy (EELS) combined with transmission electron microscopy (TEM) and Rutherford backscattering on typical μ c-SiO:H layers for thin film silicon revealed that this material consists of a mixed phase matrix of SiO and Si filaments with an oxygen atomic content *x*, between 0.4 and 0.8 [108]. Such layers have been successfully implemented on a laboratory scale in a-Si:H single junction [105], μ c-Si:H single junction [105,111], amorphous-microcrystalline silicon multi-junction tandem [108,109,112] and in a triple junction a-Si:H/a-SiGe:H/nc-Si:H [113] device to replace a-Si:H, μ c-Si:H or a-SiC:H based doped layers. On an industrially, relevant scale, μ c-SiO_x:H layers have been used for a-Si:H/ μ c-Si:H modules [102]. At the front of the PV cell, doped a-SiO_x or μ c-Si:OH, layers enhance the blue light quantum efficiency by reducing parasitic optical losses compared to non-oxide materials and thus increase the overall device [114]. Additionally, a resistive μ c-Si:OH layer between the n-layer and the back contact resulted in increased V_{OC} and PCE via shunt quenching for a-Si:H PV cells grown on rough substrates [115].

In recent developments, there have been investigations on p-type metal conductors such as WO_x [20] and MoO_3 [18] as replacements for the p-type silicon alloys in a-Si:H single junction PV cells with reasonable PV cell performance.

High efficiency in multi-junction PV cells requires that at the maximum power point all the sub-cells produce the same photocurrent, by what is termed current matching. Intermediate reflectors can be placed between adjacent sub-cells so that unused high energy photons are reflected back into the preceding wider band gap absorber while transmitting the longer wavelength light to the narrower band gap absorber below, increasing both the effective current density in multi-junction PV and the overall efficiency. Originally, ZnO was used as an intermediate reflector in tandem PV cells [116]. However, doped Si:O:H layers have been used to allow growth of the intermediate reflecting layers without a vacuum break between the two sub-cells [15,110,112,117]. The current thin film silicon PV cell stabilised efficiency of 13.4% was reported on a a-Si:H| μ c-Si:H| μ c-Si:H stack employing an n-type μ c-SiO:H intermediate reflectors [117].

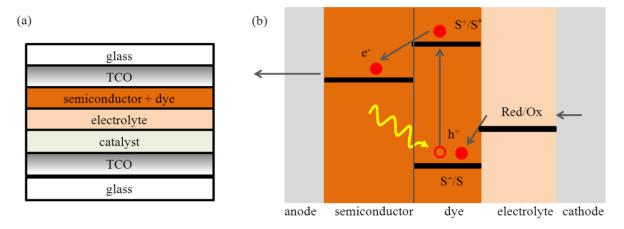
The n- and p-layer of the adjacent sub-cells in a monolithically connected multi-junction PV cell form an n-p diode that is reverse biased during forward bias operation under illumination. However, the contact between the sub-cells must be ohmic for efficient flow of charge carriers. For example, in pin/pin tandem cells, the electrons from the top cell must recombine with holes from the bottom-cell; in order to avoid charge accumulation that would block the transfer of photo-generated carriers out of the tandem cell terminals. Usually a highly doped layer is inserted between the p- and n-layer of adjacent sub-cells to facilitate charge transport by recombination of oppositely charged carriers arriving from the sub-cells. The use of an ultra-thin SiO_x layer at this interface has been shown to promote recombination and thus increase the efficiency of a-Si:H|a-Si:H [118,119] and a-Si:H| μ c-Si:H [112] tandem PV cells.

Lastly, a group of researchers in Japan have investigated the use of wideband gap a-SiO:H as an absorber pin PV cell, as with this material an open circuit voltage exceeding 1.0 V is possible. Single junction pin PV cells using a-SiO:H films as absorbers resulted in an efficiency of 5.5% with an open circuit voltage of 1.04 V [120]. Additionally, the use of a-SiO:H instead of a-Si:H, as a wide band gap absorber in a-Si:H [121] and μ c-Si:H [122] based double junction pin PV cells, has been reported to reduce the temperature coefficient of such devices. Although this material with an oxygen content of 2%–4% a-SiO:H may technically not be considered an oxide, it offers a glimpse of the scope for further insight into the development of wide band gap top cells in multi-junction devices and single junction PV cells with high terminal voltage.

5.5. Dye sensitized Solar Cells

Intrinsically doped TiO₂ [123,124] is widely used in dye sensitised solar cells (DSSC) although other wide band gap metal oxides such as ZnO and SnO₂ have also been investigated [125]. The schematic of a single junction DSSC and a sketch showing the band levels during normal operation are shown in Figure 7.

Figure 7. (a) Cell structure of a pin dye sensitised solar cell (DSSC); (b) Schematic band diagram of a DSSC under normal operation. S, S^+ and S^* stand for neutral, ionised and excited sensitizer, respectively.



Typically, a mesoporous antase phase TiO_2 film is deposited by screen printing on a conducting (usually FTO or ITO coated) glass sheet that serves as current collector. The TiO₂ is covered with a charge transfer dye also known as the sensitizer which under illumination injects an electron into the conduction band of the TiO₂. The photogenerated charges diffuse to the back and front contact, to generate an electric current, *i.e.*, the electron is transferred to the TCO layer whilst the corresponding hole is transferred to the counter electrode consisting of a catalyst such as platinum or carbon. The electronic state of the dye is restored by electron donation from an electrolyte containing a redox couple, typically iodide/tri-iodide [123]. The tri-iodide gains an electron by completion of the external current flow then passes this on to the iodide, thus the system is quasi-self-sustaining. The photovoltage obtained is related to the difference in the Fermi levels of the electrons in the semiconductor and of the redox potential of the electrolyte. Using this configuration, a PCE of 11.1% has been demonstrated [124]. However, problems with sealing make the lifetime of the device relatively short compared to all inorganic PV cells. A blocking layer is required to slow the recombination of injected electrons with the oxidised redox couple and/or the oxidised sensitizer (normally, dye molecules) and thus maintain a high open circuit voltage. Since the blocking layer forms a potential barrier between the anode and the electrolyte, a wide band gap or insulating material may fulfil this purpose. Usually an ultra-thin compact TiO₂ is used as a blocking layer however, it is expected that a nominally insulating oxide with a higher dielectric constant would perform better. Palomares et al. compared the use of ultra-thin Al₂O₃, ZrO₂ and SiO₂ as ultra-thin blocking layers and all cells using these materials showed equal or better performance than with a TiO₂ blocking layer, with the best performance for Al_2O_3 [126]. Other oxides used as blocking layers for DSSC include Nb₂O₅ [127] and MgO [128].

ZnO has become attractive as a semiconductor for DSSC since it can be easily fabricated with various nanostructures at low temperatures [129] and has a higher electron mobility than that of TiO₂. However, ZnO is less chemically stable than TiO₂ and may necessitate an additional layer for protection from the electrolyte. The possibility of using p-type semiconductors as opposed to n-type TiO₂ for DSSC has been explored where, under illumination, electrons are transferred from the valence band of the semiconductor into the HOMO of the sensitizer and then onto the oxidised species of the electrolyte. Examples of p-type semiconductors used for DSSC include NiO [130,131] and CuAlO₂ [132]. New directions in DSSC research include the development of tandem n-DSSC|p-DSSC devices which are expected to have enhanced efficiency since the V_{OC} depends only on the offset between the p-layer VBM and the n-layer CBM rather than on the redox potential of the electrolyte. The current efficiency record of 15% at 96.4 mW cm⁻² irradiation level was reported for a DSSC using a perovskite pigment to sensitise the TiO₂ [133].

5.6. Organic Photovoltaic Cells

The photo-active layer of an organic photovoltaic (OPV) cell consists of either a blend [134] or a bi-layer [135] of donor and acceptor organic molecules sandwiched between two electrodes. The most commonly used organic molecules are poly(3-hexylthiophene) (P3HT) as the electron donor and [6,6]-phenyl C₆₁-butyric acid methyl ester (PCBM) as the electron acceptor. An energy level offset exists between the lowest unoccupied molecular orbital (LUMO) of the acceptor and the conduction band edge of the acceptor material or between the highest occupied molecular orbital (HOMO) of the donor and the valence band edge of the acceptor material. When photons with sufficient energy are incident on the photoactive layer, an exciton, consisting of a coulombically bound electron-hole pair, is formed. The energy level offset at the interface between the donor and the acceptor material is used to dissociate the exciton so as to free the charge carriers [136]. The energy level offset between the donor and acceptor material also appears to determine the V_{OC} device [136] but other researchers have contradicted this result as discussed in a separate review [137]. If the exciton was generated in the donor/acceptor material, an electron/hole separated at the interface can be transferred to the acceptor/donor and then onto the cathode/anode for transport outside the cell.

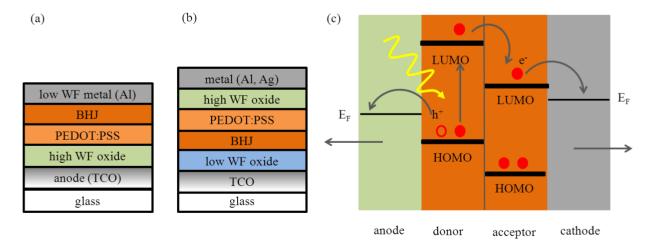
During hole injection, an electron is transferred from the organic HOMO to the CB of the metal oxide while for hole-extraction, electrons in the CB of the metal-oxide recombine with photo-generated holes at the interface with the organic "absorber". Since the optimum HOMO level of organic molecule donors for the right balance between high J_{SC} and high V_{OC} , is relatively high at between -5.2 and -5.6 eV, this has serious consequences for the choice of electrode materials used [136]. A high work function material is required at the anode so that the Fermi level E_F matches that of the HOMO of the donor. High work function metals are unsuitable for this purpose because they readily supply electrons into the donor which causes a drop in the built in potential. Poly (3,4-ethlendioxythiopene):poly(styrenesulfonate) (PEDOT:PSS), a p-type polymer, has in the past been used as a hole extraction layer/anode for high efficiency OPV. However, since PEDOT:PSS is acidic, it shortens the lifetime of the device by corroding the TCO electrode. Transition metal oxides which have a high work function, a wide band gap, are relatively chemically stable and can be prepared with low cost processing techniques have been

tested as HELs with promising results [138]. Prolonged device lifetime at similar levels of initial efficiency has been reported for transition metal oxides e.g., NiO, V_2O_5 , MoO₃ and WO₃ [17].

On the other hand, since the organic acceptor has a high electron affinity, a material with a low work function that is equal to or less than the LUMO of the acceptor, is required at the cathode to form an ohmic contact for efficient extraction of electrons and to maintain a high open circuit voltage. Additionally, the electron extracting layer (EEL) must have a high electron mobility and be able block holes from crossing the active layer cathode interface to prevent recombination of the electrons before extraction. The EEL should also act as a chemical barrier to prevent reaction between the organic active layer and the metal electrode. High optical transparency of the EEL in the wavelength range where the organic absorber is active is desirable especially for inverted configuration (which shall be discussed shortly). Low work function metal oxides such as TiO_2 [139] and ZnO [140] are popular materials for EEL as they fulfil most of the above requirements and provide better device stability than metallic or organic based electron extraction layers. The chemical conditions that make a given metal oxide suitable for use in an OPV either as a hole or electron injector have been reviewed in another article [141].

There are two types of configurations for organic based PV cells namely, the conventional and the inverted design. In the conventional design, the hole extracting layer HEL is illuminated before the BHJ and thus the TCO acts as an anode while in the inverted design the order of layers is reversed such that the TCO acts as the cathode [142] as shown in Figure 8.

Figure 8. Layout of (**a**) a conventional and (**b**) an inverted organic photovoltaic device (OPV); (**c**) Schematic of the energy level diagram showing the working principle of a conventional single junction OPV device with photogeneration occurring in the electron donor. Note that in the conventional layout, a low work function (WF) metal oxide may also be inserted between the BHJ and the low WF metal.



Generally, the PCE of OPV devices is partially limited because carrier separation can only occur where photo-generation is within the excitonic diffusion length of the interface. The highest OPV cell efficiency to date, was ~11% for a glass|ITO|ZnO|P3HT:ICBA|PEDOT:PSS|ZnO|PDTP-DFBT:PCBM |MoO₃|Ag stack [143].

5.7. Concentrator Photovoltaic Devices

In concentrator photovoltaic (PV) cells, the incident light is focused onto a small highly efficient PV cell using optical lenses or mirrors such that concentrated irradiation intensity is several hundred times higher than the incident value [143]. The advantage of this type of PV cell is that the material costs can be reduced by using a small active cell area and that less space is required compared to conventional (non-concentrator) PV cells, to achieve a given power output. The main disadvantage is that a sun tracking system is usually mandatory to maintain high efficiency throughout the day. The absorber materials usually consist of multi-junctions on a silicon or germanium wafer. The highest efficiency to date is for a quadruple junction device based on III-V compound semiconductors with a value of 44.7% for a concentration of 297% Suns [7]. For concentration exceeding 10 Suns, cooling is required to reduce the dark current component so as to maintain high values of voltage. To this end passive cooling schemes using high thermal conductivity ceramics or active cooling are used. Beryllium oxide, though toxic, and aluminium oxide, both with high thermoconductivity as well as high electrical resistance, are used in cooling stacks to remove heat dissipated in CPV devices [144].

6. Emergent PV Concepts Benefiting from the Use of Oxides

As part of the effort to make PV technology more efficient and competitive among other energy sources, the device architecture of well-known PV materials is being modified and new PV concepts are emerging, all of which benefit from the improved understanding of oxide materials. Additionally, simple and ternary oxides that were hitherto irrelevant for PV are being continuously added to the palate of materials used to explore and/push the efficiency boundaries in photovoltaic cells. While some of these materials have only functional purposes *i.e.* are not photoactive, others are used to provide the junction and even generate the photo-carriers.

6.1. Semi-Transparent PV Cells

Transparent PV cells are of interest for building integrated photovoltaic systems where they serve the dual purpose of fenestration and energy generation. For this purpose, transparent conducting oxides are the electrodes of choice at both the front and rear of the PV cell because of their visible wavelength transparency. Different types of PV cells have in the past been investigated for transparent PV namely, OPV [139,145,146], thin film silicon [147] and CIGS [148].

6.2. Bifacial PV Cells

Bifacial PV cells are designed to make use of both rear and front side reflection and thus require the use of transparent oxides as electrodes. Bifacial PV cells have been reported using CIGS [148,149], dye sensitized solar cells [150] and CdTe [151]. It is to be noted that bifacial cells may not necessarily be semi-transparent depending on the thickness and band gap of the absorber layer.

6.3. Mechanically Stacked PV Cells

Mechanically stacked PV cells offer the benefits of multi-band gap PV cells while avoiding problems associated with growing the subsequent sub-cell directly on the existing one. As the top PV cell must transmit as much of the unused light to the bottom cell, metal electrodes are undesirable and thus transparent conductors play an important role as the contacts. Some examples of mechanically stacked PV cells include CGS/CIGS [152], TiO₂ DSSC/CIGS [153]. Although ITO is a relatively "old" oxide for PV cell applications, new device concepts are still being developed using this material. For instance, in Japan, mechanically stacked multi-junction Si|Si and, InGaP|GaAs on Ge, PV cells, using an adhesive combined with ITO particles, have been successfully demonstrated [154].

6.4. Oxide Nanosized Materials for PV

The use of nano-sized materials in PV cells has been fashionable since the early 2000s [137] after the demonstration of a high efficiency DSSC using TiO₂ nano-particles [123]. Naturally, oxides being simple to prepare in nano-particle size, play an important role in the drive to achieve high efficiency in "nano-based" PV devices. Al₂O₃ nanoparticles have been used to improve light in coupling in silicon nanowire PV cells to increase the quantum efficiency [155]. ZnO nanowires have been used for DSSC [156]. The field of nano-sized materials in PV is too wide to discuss on its own here and overlaps several other technologies such as quantum dots, hybrid organic/inorganic PV cells of which, some examples are presented.

6.5. Photonic Crystals for PV

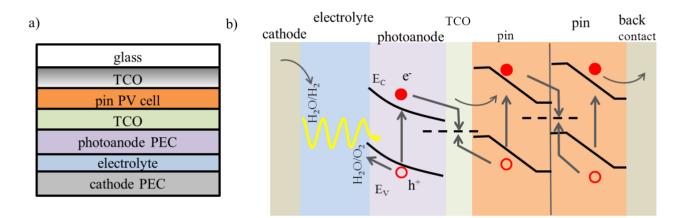
If two media of differing dielectric constant are adjacent to each other, light will propagate slower in the medium of higher dielectric constant. If the two media are spatially arranged, then a spatial periodicity in their dielectric constants exists and this could be in 1-, 2- or 3-dimensions. Such materials are known as photonic crystals PCs. Due to the periodicity of the dielectric constants, interferences will exist that prevent specific frequencies from propagating through the PC giving rise to forbidden and allowed bands. If a photon of a wavelength comparable to the periodicity of the lattice of the photonic crystal is reflected back it is thus blocked from passing through the PC. Recently, photonic crystals have been integrated into different PV devices to improve the light management. A thin film silicon tandem PV cell using a photonic crystal consisting of inverted ZnO opals as an intermediate reflecting layer has been experimentally demonstrated, although efficiency values were not provided [157]. Photonic crystals, whereby the optical contrast is realised between a patterned BHJ blend (high refractive index), and ZnO (low refractive index), have also been used to increase the absorption in organic PV cells compared to flat devices [158]. Photonic crystals consisting of inverse opal TiO₂ have been used to increase the absorption and thus photogeneration in dye sensitized solar cells [159].

6.6. Photovoltaic Integrated Devices for Stand-Alone Functionality

PV integrated optoelectronic devices are attractive because the omission of external wire connections minimises resistance losses, makes the device compact and simplifies the fabrication. At least one of the devices must be semitransparent to allow transmission of photons to the adjacent one.

In hybrid photovoltaic-photoelectrochemical (PEC) devices part of the incident photons are used to photocatalytically split water into oxygen and hydrogen and the rest to generate a photovoltage. The PEC device consists of a photocatalyst, at the anode, and a cathode separated by an aqueous electrolyte [160,161]. When light of high enough energy is incident on the photoanode, electron-hole pairs are generated. The photogenerated holes oxidise water at the surface of the photocatalyst releasing oxygen gas and hydrogen ions. The electrons are transferred to the cathode via an external circuit, where they reduce the H⁺ ions to give hydrogen. Since anodic electrode materials with a high enough band gap to provide a voltage higher than the dissociation voltage of water are rare, the use of bias potential supplied by an integrated photovoltaic cell is attractive. The sketch in Figure 9 shows the layout of the monolithically connected PV/PEC cell and the energy level diagram of such a device.

Figure 9. (a) Layer stack and (b) energy level diagram of a photovoltaic-photoelectrochemical (PV-PEC) hybrid device.



Ideally, the PV cell should be capable of delivering a high enough voltage level to exceed the dissociation voltage of water (1.23 V) and to compensate voltage losses along the various interfaces of the device. The PV cell creates a photovoltage and current as a result of incident light transmitted through the transparent PEC device and the operating point of the hybrid device is determined by the intersection of the J-V curves of the PV and the PEC device [160]. The use of a metal oxide photoanode allows the use of a device consisting of a monolithically grown PEC and PV cell layer stack immersed in the electrolyte since when well-chosen; the metal oxide provides chemical protection to the rest of the device [160]. Multi-junction thin film silicon PV cells are an attractive partner for PV/PEC cells because the amorphous cell already provides ~900 mV. First devices using a-Si/a-Si double junctions [162] and crystalline Si|a-Si|GaP in hybrid PV PEC devices have been demonstrated [163].

Another concept is the stand-alone PV powered electrochromic window (ECW) which combines a PV cell with a fenestration device that reversibly changes its colour/transparency depending on the voltage applied to its terminals. Several such devices have been described in the literature [164,165]. Since it is desired that the ECW darkens under strong sunlight, increasing the irradiation intensity on the PV cell would increase its current output which would in turn increase the voltage bias across the ECW, thus reducing its transparency appropriately to achieve a shading effect. Under low sunlight intensity, the PV device is inactive and the ECW is highly transparent allowing maximum light transmission into

the building. Clearly, metal oxides used instead of metal films as electrodes, play an important role in ensuring that the whole device is semi-transparent in the bleached state.

6.7. Luminescent Spectral Converters

A significant part of the sunlight incident on contemporary PV cells cannot be used for photogeneration. Photons with energy less than the band gap energy are transmitted or reflected out of the PV cell while those higher than the band gap energy are wasted via thermalisation of carriers as already summarised in Figure 1. Luminescent spectral up- and down-converters are materials that absorb photons of a certain energy level and via electron transitions, re-emit them at higher or lower energy levels, respectively making them attractive PV cell components in the bid to enhance the photoconversion efficiencies.

The oxides of rare earth RE and lanthanide Ln metals that is, Sc, Y and La in group 3 and the lanthanides, exhibit photoluminescence. The electronic structure of their oxides consists of a valence band of filled O 2p states, a band gap of the order of 5.5 eV, a main conduction band of empty Ln 5d states, and filled and empty Ln 4f states which can lie in these bands or in the main band gap [19]. The partially filled 4f electron shell is shielded by filled 5s2 and 5p6 shells making the luminescence behavior largely independent of the surrounding conditions such as crystalline structure or presence of a foreign host material [166]. Although the RE- and Ln-oxides are wide band materials, photoabsorption caused by local excitations within the 4f electron shell lead to optical transitions that appear as sharp emission spectra.

In up-conversion, the up-converter film may be placed behind the PV cell where it absorbs the transmitted long wavelength photons. Ideally, the absorption of two sub-band gap photons by the up-converter should lead to the emission of one photon with energy for which the PV absorber material has the highest spectral response [167]. The up-converter should also have an energy band gap equal to that of the PV absorber. La₂MO₂O₉: Yb, R (R = Er, Ho) films screen printed on top of silicon wafer PV cells have been shown to increase the overall cell efficiency compared to bare cells [168]. In this case, La₂MO₂O₉ was the host material while Yb³⁺ was the sensitizer which triggers the process by absorbing low energy photons then re-emits the photons at another energy level to the activators *i.e.*, Er or Ho where via a further luminescence process, higher energy photons are emitted for absorption by the PV cell absorber for photoconversion.

On the other hand with down conversion, the down-converter film should absorb one photon and re-emit two photons both of which with an energy at which the PV absorber has a high spectral response [169]. The down-converter should ideally have an energy band gap double as wide as that of the PV absorber and should possess impurity levels at the centre. Gd_2O_3 :Eu nanocrystals dispersed in mesoporous TiO₂ enhance the DSSC efficiency by excitation of Gd_2O_3 by UV light which transfers charge to Eu then onto the TiO₂ [170]. In another configuration, through Eu³⁺ and Sm³⁺ doping, UV light absorbed by mesoporous TiO₂ can be re-emitted over a relatively broad band from 550 to 750 nm [171]. The efficiency of DSSC using TiO₂ doped by the lanthanides Sm³⁺ and Eu³⁺ could be enhanced compared to that of undoped TiO₂ [172].

6.8. Hybrid Organic-Inorganic PV Cells

Hybrid organic-inorganic PV cells are being investigated in order to benefit from a combination of the promise of low material cost of organics and the ability to tune the band gap of inorganic materials [137]. In such devices, an inorganic material such as silicon, CdSe or a metal oxide replaces the organic electron acceptor. In one development, the neodymium oxide is combined with PCBM to form an organic-inorganic hybrid BHJ cell [173]. The absorption of photons of energy $\geq 2 \text{ eV}$ significantly improved and was accompanied by an increase in the device photocurrent and photo-conversion efficiency. The increased photocurrent was attributed to charge transfer between Nd₂O₃ and the PCBM as proved by absorption peaks measured by transient absorption pump-probe spectroscopy, corresponding to valence- to f-band transitions in Nd₂O₃.

6.9. Extremely Thin Absorber ETA Solar Cells

ETA solar cells are pn heterojunction devices consisting of a nanostructured wide gap semiconductor conformally coated by a very thin p-type absorber layer [174]. The nanostructure of the pn junction increases the optical path of the light in the device thus allowing the use of a thinner absorber which improves the photocarrier collection efficiency. The ETA is preferably deposited onto the nanostructured substrate using solution based processing to ensure a close contact at the pn junction. The n-contact and absorber materials are chosen so that the band alignment allows electron flow from the absorber to the n-contact while a large valence band offset block hole transfers across this interface. Holes are transferred across the absorber/metal interface. As with other types of semiconductor PV cells, such as CIGS or CdTe based types, one electrode is normally a transparent electrode, usually a TCO film and the other, a metal. As an example, a glass|SnO₂:F|TiO₂|CdTe|Au device with only 170 nm of CdTe could generate a short circuit density of 8.9 mA/cm ²[174] which is a third of the value of state of the art CdTe PV cells with an absorber thickness of a few microns [93].

6.10. Perovskite Absorber PV Cells

A PV device based on a schottky junction using a $SrTiO_3$ crystal as the absorber has been demonstrated [51]. By using perovskite PV cells based on methylammonium lead halides (CH₃NH₃PbX₃), where *X* is Ch, I or Br, impressive PV cell performance has been achieved by several groups. Efficiency values of up to 10.9% can be achieved with a glass|SnO₂:F|compact n-type TiO₂|(CH₃NH₃PbI₂Cl) + mesoporous TiO₂ or Al₂O₃|p-type 2,29,7,79-tetrakis-(N,N-di-p-methoxyphenylamine) 9,99-spirobifluorene (spiro-OMeTAD)|metal device stack [175]. Recently, an even higher efficiency of 15.4% was obtained by using a similar structure using a physical vapour deposited (CH₃NH₃PbX₃) that omitted the mesoporous oxide but retained the compact TiO₂ as an electron selective layer [176].

6.11. "New" Single Cation Oxides for PV

Lead oxide has also been investigated as an absorber material in PV cells although the efficiency is still too low [40]. Graphene oxide (GO) consists of hexagonal ring networks of sp2 hybridized carbon atoms of graphene whose stacked planes are randomly disrupted by sp3 hybridized carbon atoms

covalently bonded to oxygen functional groups [177]. The conductivity of GO can be varied from a semi-metallic through semi-conductor to insulating by increasing the fraction of sp3 C-O bonds [177]. Moreover, GO films that are a few nm thick behave like a conducting transparent oxide making it an interesting material for opto-electronic applications. GO has been employed as a hole [178,179] and electron [179] transporting layer in organic PV cells.

Anodic aluminium oxide (AAO) is made by anodising aluminium foils or thin films on a foreign substrate by electrolysis in oxalic, citric or phosphoric acid [180]. When a pattern is imprinted on the alumin úm prior to the anodization, ordered or periodic structures are formed after the anodization. Although AAO is well known, only a few exploratory studies have been directed to PV cell application. AAO can be used as an angular selective back scatterer in semi-transparent OPV [146]. Tsao *et al.* studied the use of AAO structures as back surface reflectors for light trapping in thin film silicon PV cells but did not report the achievable PCE values [180]. AAO has also been successfully demonstrated as suitable for large area formation of antireflective coatings for PV cells [181].

6.12. Ferro Electric Photovoltaics

Unlike conventional photovoltaics, the open circuit voltage produced by ferroelectric photoactive materials exceeds their band gap due to a polarisation related charge separation mechanism. This effect was observed, in the 1970s, for several materials including LiNbO₃ [182]. Recently, more studies have shown that the value of the above-band gap photovoltage of ferroelectric BiFeO₃ can be tuned by varying the number of nanometre scale domain walls with alternating polarity, and additionally, by varying the applied electrical field [183]. However, the efficiency of such devices based on ferroelectric materials such as BiFeO₃ and Pb(Zr,Ti)O₃ (PZT) remains very low due to the low fill factor and Jsc [184–186] PV cells using KNbO₃, another perovskite ferroelectric material, as the absorber have been reported [53].

6.13. All Oxide PV

As a result of the (re)emergence of oxide semiconductors with band gaps low enough to absorb light in the VIS-NIR wavelength spectrum, the concept of all-oxide photovoltaics has become an interesting research topic [187]. The oldest "all oxide" PV cell technology makes use of a pn junction consisting of Cu₂O and an n-type transparent conductor with efficiencies ranging from 0.4% to 3.8% as reviewed recently [21]. Since then, a current record efficiency of 5.38% has been achieved by including a pulsed laser deposited Ga₂O₃ with a work function of 5.08 eV which lies close to the electron affinity of Cu₂O in an Al-doped ZnO|non-doped Ga₂O₃|Cu₂O hetero-junction PV cell [23].

A more recent development in "all oxide" PV makes the use of layered oxide heterostructures consisting of insulating oxides of differing band gap that become photo-active when they form a heterojunction, as absorber materials [52]. This works on the principle that above a critical thickness, the interface of these insulating materials becomes conductive, for example, a concept consisting of a gap-graded oxide heterostructure cell made up of several LaVO₃|SrTiO₃ double layers which have an effective band gap of 1.1eV [52]. The n- and p-type regions of the PV device exist at the $(TiO_2|[LaO]^+)$ and the $(SrO|[VO_2]^-)$ interfaces, respectively. Light incident on the device generates photocarriers in the LaVO₃ layers which are then separated by the built in voltage that develops between the n- and p-regions.

6.14. Quantum Effect Photovoltaic Devices

Quantum effect photovoltaics use the quantum effect to vary the spectral response of the absorber layer by using quantum dots (QD) or quantum wells (QW). In quantum dot (QD) photovoltaic devices, the band gap and thus spectral response of the photoactive layer is varied by tuning the quantum size of the material rather than varying the material composition as is done for conventional photovoltaics. When the diameter of a particle is reduced below the characteristic dimensions of the electron and hole wave-function of the host material, its energy levels are shifted into the bands of the bulk medium thus varying the width of the band gap. Generally, for PV applications, the p-type QD absorber is embedded in a host material usually a wide band gap n-type oxide and functions much like the dye in DSSCs described before, with the advantage that device lifetime may be prolonged [188,189]. When photons are absorbed by the QD, an electron-hole pair is formed and the electrons are transferred into the conduction band of the semiconductor. Chalogenide based QDs as sensitizers on wide band gap semiconductor oxides including TiO₂, ZnO, SnO₂, Nb₂O₅ and Ta₂O₅ have been investigated for PV cell application [190–192]. MoO₃ has been used as a large work function electrode to ensure an ohmic contact at the rear of a TiO₂ cell with Pbs QDs thus achieving an efficiency of 3.5% [189].

The use of colloidal quantum dots (CQD) with an absorption band edge around 1600 nm has opened the way for infra-red photovoltaics [193]. This is an important breakthrough since nearly half of the sun's energy lies in the near infrared wavelength region and thus in order to increase the efficiency of the current PV devices, materials that are photoactive in this energy region are vital. An efficiency value as high as 7% has been reported for a glass|SnO₂:F|TiO₂/ZnO|CQD|MoO₃|Au|Ag device [194].

Quantum well QW solar cells consist of an intrinsic absorber layer made up of a succession of stacks consisting of a lower band gap semiconductor (well) sandwiched between two higher band gap semiconductors (barrier). The intrinsic layer is in turn sandwiched between a p-type and n-type semiconductor forming a pin junction that confines the photogenerated electrons in two rather than three dimensions as in conventional PV cells. Since the energy of the electrons inside the i-layer is lower than that of the p and n layers, the flow of charge is confined to well-defined regions. The lower band gap increases light absorption but traps the photo-generated carriers and therefore it is desirable to reduce the number of quantum wells. The efficiency of quantum well PV cells can be significantly enhanced by integration of dielectric nanoparticles such as SiO₂ which scatter normally incident light into lateral propagating optically confined modes within the wave guiding multiple quantum well intrinsic layer [195]. This approach enables highly efficient photon absorption and photo current generation in the ultra-thin layers and also improves collection of photo-generated charge carriers because of the high electric field in the QW region.

7. Conclusion

Oxides are an important component of PV cells and shall continue to be so in the future. Due to the diverse applications of oxides in PV cells, only a snap shot can be made of the range of devices that have been explored. On the one hand, we have the traditional oxides for various functionalities and on the other, new oxide materials are being introduced for use in PV. While the transparent conducting oxides of indium, zinc and tin are important as electrodes in most PV cell technologies, TiO₂ has become the

model material for PV cells based on charge transfer to a sensitised semiconductor. The oxides of silicon and aluminium, both members of the semi-metal group, when highly insulating can be used for passivation due to their high dielectric constant. The transition metal oxides with high work functions are now routinely used for organic PV cells as electrode buffer materials to maximise the cell voltage and to prevent leakage currents. Other oxides, such as those of copper and lead have been used as absorber materials. More exotic multinary oxides such as the ferroelectric perovskites BiFeO₃ and KNbO₃ are used as absorbers with the promise of high cell voltage. Lanthanide host oxides and lanthanide doped oxides have been introduced as wide band spectral converters to enhance the spectral response of PV cells beyond the normal absorption band of the absorber material. Much as this review has focused on examples of applications of oxide materials where PV cell performance has been experimentally demonstrated, the contribution and importance of theoretical calculations towards these and future developments cannot be overstated.

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Conflicts of Interest

The author declares no conflict of interest.

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